Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/681,015	YOON ET AL.	
	Examiner	Art Unit	
	Phu K. Nguyen	2673	

SEARCHED			
Class	Subclass	Date	Examiner
345	473	9/30/2005	PN
707	501.1	9/30/2005	PN

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
WEST search SEE ATTACHED	9/30/2005	PN
Dialog, IEEE, ACM search SEE ATTACHED	9/30/2005	PN
Inventor Name search	9/30/2005	PN